## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | NAKAHATA ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*	·	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name .	Classification
*	Α	US-2005/0142879	06-2005	Atwater et al.	438/689
*	В	US-6,652,658	11-2003	Mori et al.	134/1
*	С	US-5,032,203	07-1991	Doy et al.	156/345.14
*	D	US-5,376,222	12-1994	Miyajima et al.	216/88
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
		US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	020-44726	02-1990	JP	Fujimi	
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.